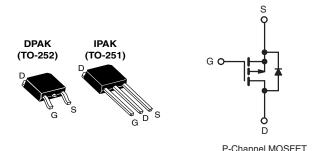
# IRFR9010, IRFU9010, SiHFR9010, SiHFU9010

Vishay Siliconix

# Power MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	- 50				
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = - 10 V 0.50				
Q <sub>g</sub> (Max.) (nC)	9.1				
Q <sub>gs</sub> (nC)	3.0				
Q <sub>gd</sub> (nC)	5.9				
Configuration	Single				



### **FEATURES**

 Surface Mountable (Order IRFR9010. SiHFR9010)



**FREE** 

 Straight Lead Option (Order as IRFU9010, SiHFU9010)

COMPLIANT HALOGEN

Repetitive Avalanche Ratings

Dynamic dV/dt Rating

Simple Drive Requirements

Ease of Paralleling

 Material categorization: For definitions of compliance please see www.vishay.com/doc?99912

### DESCRIPTION

The power MOSFET technology is the key to Vishay's advanced line of power MOSFET transistors. The efficient geometry and unique processing of this latest "State of the design achieves: very low on-state resistance combined with high transconductance; superior reverse energy and diode recovery dV/dt capability.

The power MOSFET transistors also feature all of the well established advantages of MOSFETs such as voltage control, very fast switching, ease of paralleling and temperature stability of the electrical parameters.

Surface mount packages enhance circuit performance by reducing stray inductances and capacitance. The DPAK (TO-252) surface mount package brings the advantages of power MOSFETs to high volume applications where PC Board surface mounting is desirable. The surface mount option IRFR9010, SiHFR9010 is provided on 16 mm tape. The straight lead option IRFU9010, SiHFU9010 of the device is called the IPAK (TO-251).

They are well suited for applications where limited heat dissipation is required such as, computers and peripherals, telecommunication equipment, DC/DC converters, and a wide range of consumer products.

ORDERING INFORMATION						
Package	DPAK (TO-252)	DPAK (TO-252)	DPAK (TO-252)	IPAK (TO-251)		
Lead (Pb)-free and Halogen-free	SiHFR9010-GE3	SiHFR9010TR-GE3a	SiHFR9010TRL-GE3a	SiHFU9010-GE3		
Lood (Db) from	IRFR9010PbF	IRFR9010TRPbFa	IRFR9010TRLPbFa	IRFU9010PbF		
Lead (Pb)-free	SiHFR9010-E3	SiHFR9010T-E3a	SiHFR9010TL-E3a	SiHFU9010-E3		

### Note

See device orientation.

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)					
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		$V_{DS}$	- 50	V	
Gate-Source Voltage		$V_{GS}$	± 20	7 v	
Continuous Drain Current	$V_{GS}$ at - 10 V $T_{C} = 25 ^{\circ}\text{C}$ $T_{C} = 100 ^{\circ}\text{C}$	1	- 5.3		
Continuous Drain Current	$V_{GS}$ at - 10 $V_{CS}$ $T_{C} = 100 ^{\circ}C$	l <sub>D</sub>	- 3.3	Α	
Pulsed Drain Current <sup>a</sup>	I <sub>DM</sub>	- 21			
Linear Derating Factor		0.20	W/°C		
Single Pulse Avalanche Energy <sup>b</sup>	E <sub>AS</sub>	136	mJ		
Repetitive Avalanche Current <sup>a</sup>		I <sub>AR</sub>	- 5.3	А	
Repetitive Avalanche Energy <sup>a</sup>		E <sub>AR</sub>	2.5	mJ	
Maximum Power Dissipation	$P_{D}$	25	W		
Peak Diode Recovery dV/dt <sup>c</sup>	dV/dt	5.8	V/ns		
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	- °C		
Soldering Recommendations (Peak Temperature) <sup>d</sup>	for 10 s		300	1	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 14).
- b.  $V_{DD} = -25$  V, starting  $T_J = 25$  °C, L = 9.7 mH,  $R_g = 25$   $\Omega$ , peak  $I_L = -5.3$  A. c.  $I_{SD} \le -5.3$  A,  $dI/dt \le -80$  A/µs,  $V_{DD} \le 40$  V,  $T_J \le 150$  °C, suggested  $R_g = 24$   $\Omega$ .
- d. 0.063" (1.6 mm) from case.



# IRFR9010, IRFU9010, SiHFR9010, SiHFU9010

Vishay Siliconix

THERMAL RESISTANCE RATINGS					
PARAMETER SYMBOL MIN. TYP. MAX. UNIT					
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	-	110	
Case-to-Sink	R <sub>thCS</sub>	-	1.7	-	°C/W
Maximum Junction-to-Case (Drain)a	R <sub>thJC</sub>	-	-	5.0	

### Note

a. Mounting pad must cover heatsink surface area.

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							·
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>G</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-	-	V
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub>	<sub>S</sub> = V <sub>GS</sub> , I <sub>D</sub> = - 250 μA	- 2.0	-	- 4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 20 V	-	-	± 500	nA
Zona Cata Valtaga Drain Current		V <sub>DS</sub> =	max. rating, V <sub>GS</sub> = 0 V	-	-	- 250	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 0.8 \text{ x m}$	ax. rating, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	- 1000	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 10 V	I <sub>D</sub> = - 2.8 A <sup>b</sup>	-	0.35	0.5	Ω
Forward Transconductance	9fs	V <sub>DS</sub>	≤ - 50 V, I <sub>DS</sub> = - 2.8 A	1.1	1.7	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>		$V_{GS} = 0 V$	-	240	-	
Output Capacitance	C <sub>oss</sub>	1 .	$V_{DS} = -25 V$ ,	-	160	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f=	= 1.0 MHz, see fig. 9	-	30	-	
Total Gate Charge	Qg		$I_D = -4.7 \text{ A}, V_{DS} = 0.8 \text{ x max}.$	-	6.1	9.1	
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = -10 \text{ V}$	= -10 V rating, see fig. 16 (Independent operating	-	2.0	3.0	nC
Gate-Drain Charge	$Q_{gd}$		temperature)	-	3.9	5.9	
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = - 25 V, I <sub>D</sub> = - 4.7 A,		-	6.1	9.2	- ns
Rise Time	t <sub>r</sub>			-	47	71	
Turn-Off Delay Time	t <sub>d(off)</sub>		$R_g$ = 24 Ω, $R_D$ = 5.6 Ω, see fig. 15 (Independent operating temperature)		13	20	
Fall Time	t <sub>f</sub>				35	59	
Internal Drain Inductance	L <sub>D</sub>	Between lea 6 mm (0.25	") from	-	4.5	-	ъU
Internal Source Inductance	L <sub>S</sub>	die contact	~/	i	7.5	-	· nH
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET sy showing the		-	-	- 5.3	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	- 18	
Body Diode Voltage	$V_{SD}$	$T_{J} = 25^{\circ}$	$^{\circ}$ C, $I_{S} = -5.3$ A, $V_{GS} = 0$ $V^{b}$	ı	-	- 5.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T. = 25 °C	I_ = _ 4 7 A dI/dt = 100 A/usb	33	75	160	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$	$T_J = 25 ^{\circ}\text{C}, I_F = -4.7 \text{A},  \text{dI/dt} = 100 \text{A/}\mu\text{s}^{\text{b}}$		0.090	0.22	0.52	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )					L <sub>D</sub> )

## Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 14).
- b. Pulse width  $\leq 300~\mu s;$  duty cycle  $\leq 2~\%.$

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# TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

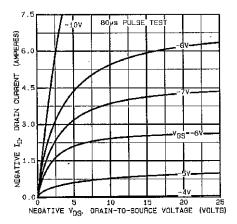


Fig. 1 - Typical Output Characteristics

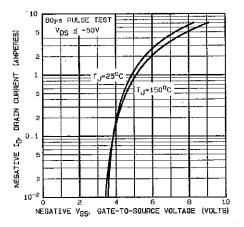


Fig. 2 - Typical Transfer Characteristics

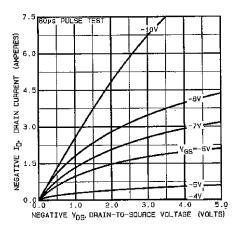


Fig. 3 - Typical Saturation Characteristics

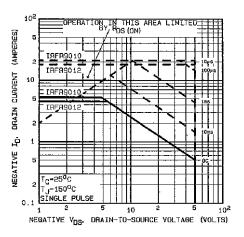


Fig. 4 - Maximum Safe Operating Area

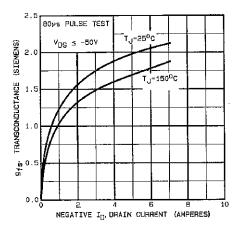


Fig. 5 - Typical Transconductance vs. Drain Current

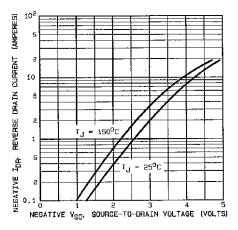


Fig. 6 - Typical Source-Drain Diode Forward Voltage

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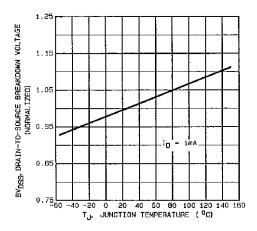


Fig. 7 - Breakdown Voltage vs. Temperature

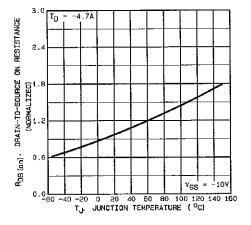


Fig. 8 - Normalized On-Resistance vs. Temperature

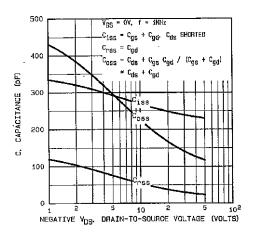


Fig. 9 - Typical Capacitance vs. Drain-to-Source Voltage

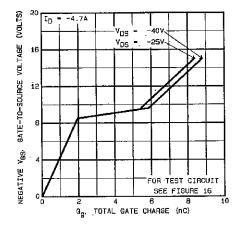


Fig. 10 - Typical Gate Charge vs. Gate-to-Source Voltage

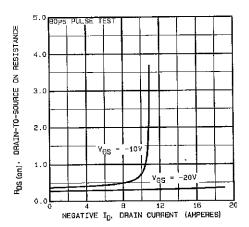


Fig. 11 - Typical On-Resistance vs. Drain Current

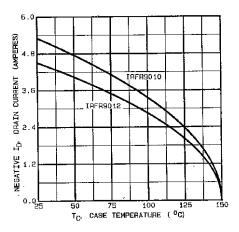


Fig. 12 - Maximum Drain Current vs. Case Temperature

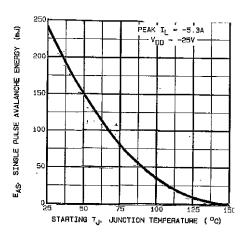


Fig. 13a - Maximum Avalanche vs. Starting Junction Temperature

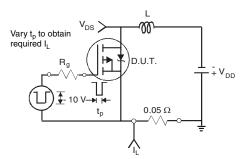


Fig. 13b - Unclamped Inductive Test Circuit

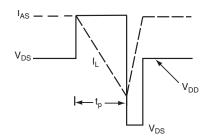


Fig. 13c - Unclamped Inductive Waveforms

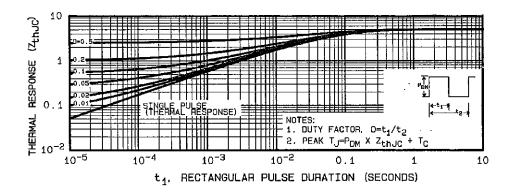


Fig. 14 - Maximum Effective Transient Thermal Impedance, Junction-to-Case vs. Pulse Duration

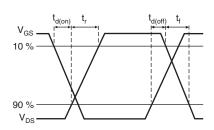


Fig. 15a - Switching Time Waveforms

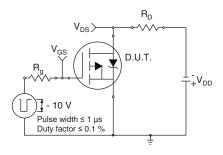


Fig. 15b - Switching Time Test Circuit

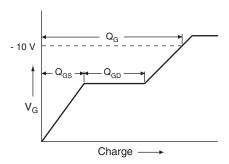


Fig. 16a - Basic Gate Charge Waveform

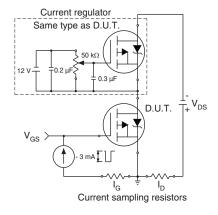
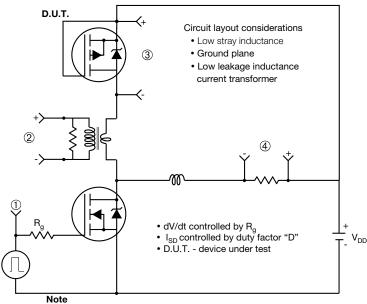


Fig. 16b - Gate Charge Test Circuit

### Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver

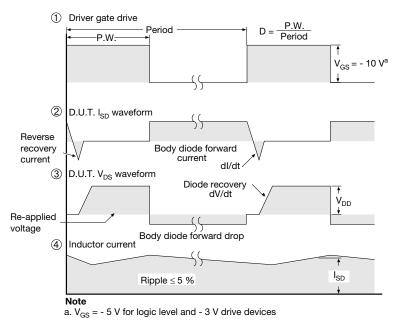


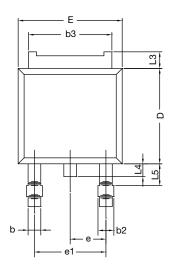
Fig. 17 - For P-Channel

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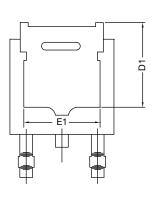


TO-252AA Case Outline

# **VERSION 1: FACILITY CODE = Y**







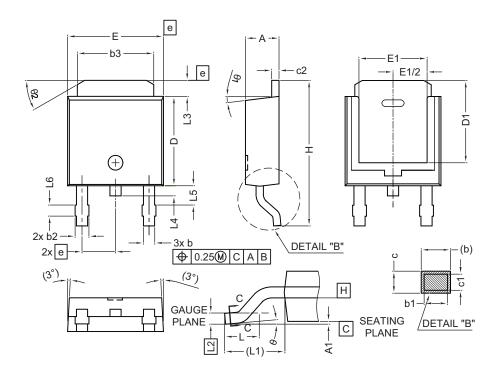
	MILLIMETERS		
DIM.	MIN.	MAX.	
A	2.18	2.38	
A1	-	0.127	
b	0.64	0.88	
b2	0.76	1.14	
b3	4.95	5.46	
С	0.46	0.61	
C2	0.46	0.89	
D	5.97	6.22	
D1	4.10	-	
Е	6.35	6.73	
E1	4.32	-	
Н	9.40	10.41	
е	2.28	BSC	
e1	4.56 BSC		
L	1.40	1.78	
L3	0.89	1.27	
L4	-	1.02	
L5	1.01	1.52	

## Note

• Dimension L3 is for reference only



# **VERSION 2: FACILITY CODE = N**



	MILLIMETERS		
DIM.	MIN.	MAX.	
Α	2.18	2.39	
A1	-	0.13	
b	0.65	0.89	
b1	0.64	0.79	
b2	0.76	1.13	
b3	4.95	5.46	
С	0.46	0.61	
c1	0.41	0.56	
c2	0.46	0.60	
D	5.97	6.22	
D1	5.21	=	
E	6.35	6.73	
E1	4.32	-	
е	2.29 BSC		
Н	9.94	10.34	

	MILLIMETERS		
DIM.	MIN.	MAX.	
L	1.50	1.78	
L1	2.74	ł ref.	
L2	0.51	BSC	
L3	0.89	1.27	
L4	-	1.02	
L5	1.14	1.49	
L6	0.65	0.85	
θ	0°	10°	
θ1	0°	15°	
θ2	25°	35°	

# Notes

- Dimensioning and tolerance confirm to ASME Y14.5M-1994
- All dimensions are in millimeters. Angles are in degrees
- Heat sink side flash is max. 0.8 mm
- Radius on terminal is optional

ECN: E19-0649-Rev. Q, 16-Dec-2019

DWG: 5347



# **TO-251AA (HIGH VOLTAGE)**



Section B - B and C - C

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	2.18	2.39	0.086	0.094
A1	0.89	1.14	0.035	0.045
b	0.64	0.89	0.025	0.035
b1	0.65	0.79	0.026	0.031
b2	0.76	1.14	0.030	0.045
b3	0.76	1.04	0.030	0.041
b4	4.95	5.46	0.195	0.215
С	0.46	0.61	0.018	0.024
c1	0.41	0.56	0.016	0.022
c2	0.46	0.86	0.018	0.034
D	5.97	6.22	0.235	0.245

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D1	5.21	-	0.205	-
Е	6.35	6.73	0.250	0.265
E1	4.32	-	0.170	-
е	2.29	BSC	2.29	BSC
L	8.89	9.65	0.350	0.380
L1	1.91	2.29	0.075	0.090
L2	0.89	1.27	0.035	0.050
L3	1.14	1.52	0.045	0.060
θ1	0'	15'	0'	15'
θ2	25'	35'	25'	35'

ECN: S-82111-Rev. A, 15-Sep-08

DWG: 5968

### Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimension are shown in inches and millimeters.
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.13 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.
- 4. Thermal pad contour optional with dimensions b4, L2, E1 and D1.
- 5. Lead dimension uncontrolled in L3.
- 6. Dimension b1, b3 and c1 apply to base metal only.
- 7. Outline conforms to JEDEC outline TO-251AA.

Document Number: 91362 Revision: 15-Sep-08



# **RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)**



Recommended Minimum Pads Dimensions in Inches/(mm)

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APPLICATION NOTE



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